

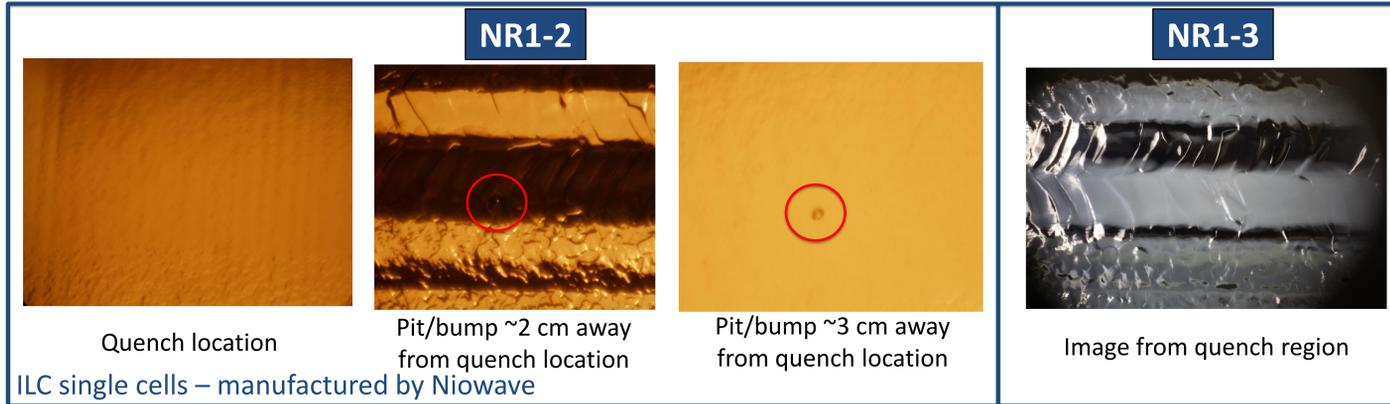
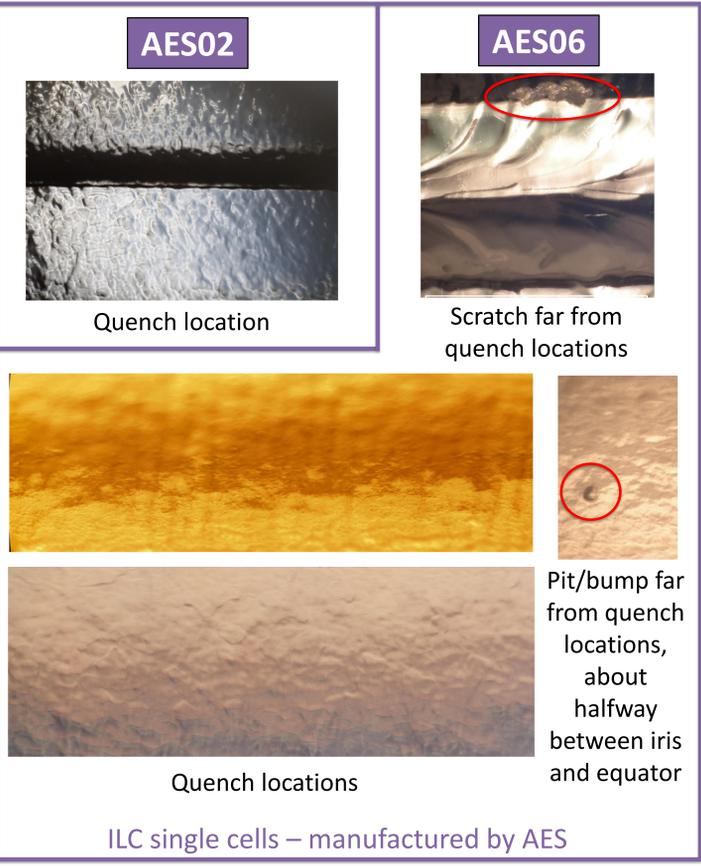
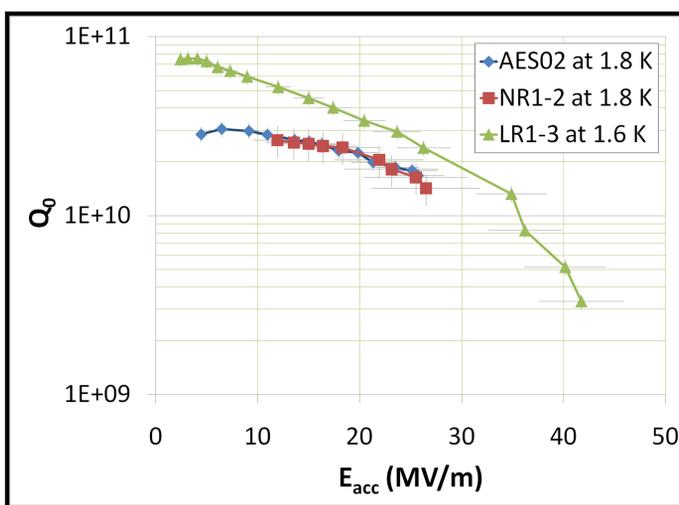
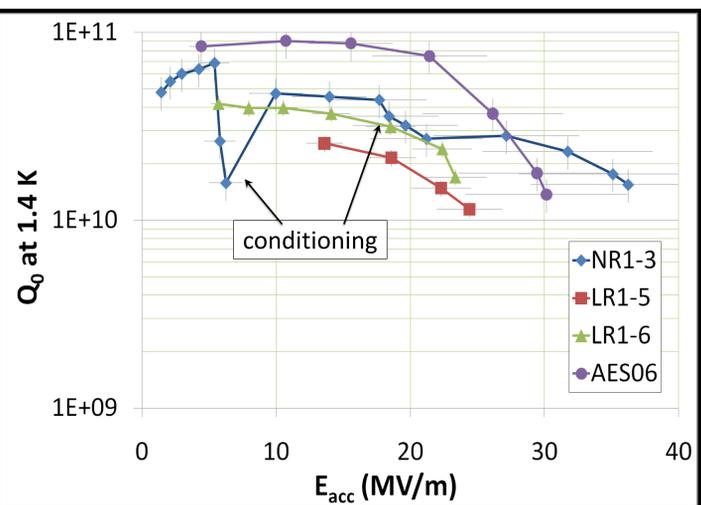
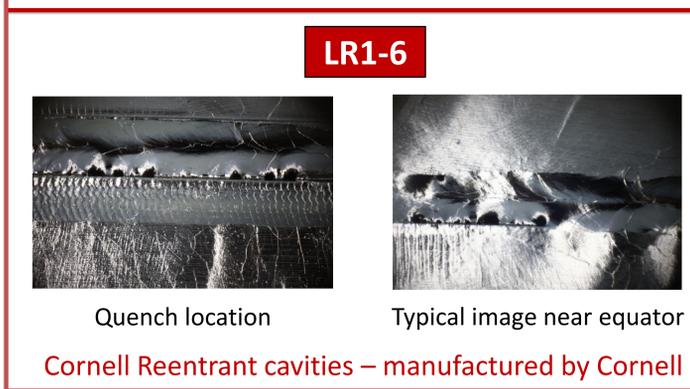
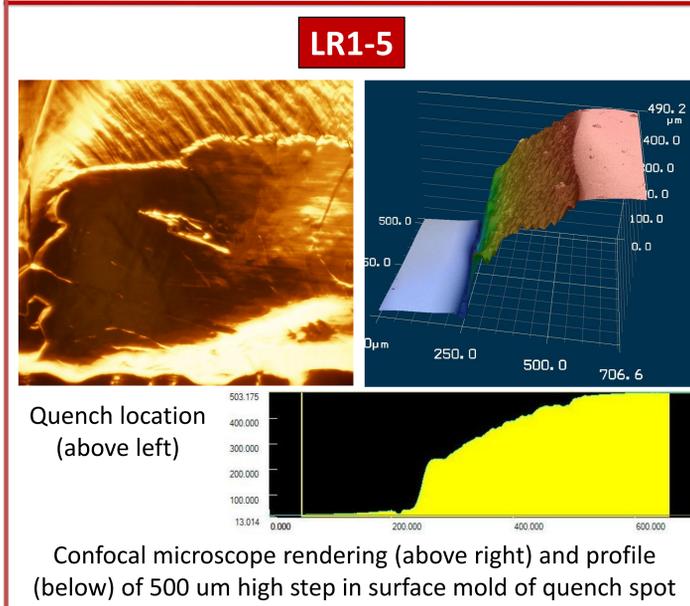
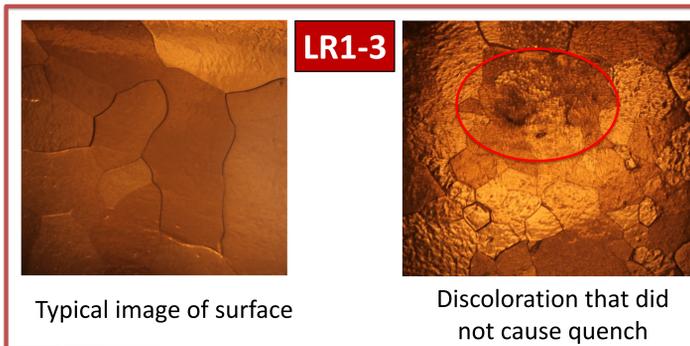


# QUENCH STUDIES IN LARGE AND FINE GRAIN Nb CAVITIES

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**Abstract:** Quenches without radiation are sometimes observed at fields between 25 and 40 MV/m in niobium SRF cavities. The cause for this limitation is not well understood. This work presents results from an investigation into quenches in seven 1.3 GHz single-cell cavities performing above 25 MV/m. Studies were carried out on both fine grain and large grain cavities in ILC and Cornell Reentrant shape geometries. The quenches were located by triangulation using Cornell oscillating superleak transducers and then cavities were optically inspected to determine the surface conditions of the cavity at the quench location. Optical inspection images are presented as well as 3D recreations of quench spots generated using a surface mold and a confocal microscope.

| cavity name                          | AES02                      | AES06   | NR1-2   | NR1-3                      | LR1-3                          | LR1-5  | LR1-6                                      |
|--------------------------------------|----------------------------|---|---|----------------------------|--------------------------------|--|--|
| shape                                | ILC                        | ILC   | ILC   | ILC                        | reentrant                      | reentrant  | reentrant                                  |
| grain                                | fine                       | fine  | fine  | fine                       | fine                           | large  | large                                      |
| last main chemistry                  | ~300 um VEP                | ~300 um VEP   | ~200 um VEP   | ~300 um VEP                | VEP (C. barrel polish prior)   | BCP  | BCP  |
| 800 C bake                           | 2h                         | 2h  | 2h  | 2h                         | 2h                             | n/a  | n/a  |
| final chemistry                      | micro-VEP                  | micro-VEP   | micro-VEP   | micro-VEP                  | micro-VEP                      | n/a  | n/a  |
| 120 C bake                           | 20 h                       | 48h   | 48h   | 48h                        | 48h                            | 48h  | 48h  |
| max acc. field                       | 27 MV/m                    | 30 MV/m   | 27 MV/m   | 36 MV/m                    | 42 MV/m                        | 24 MV/m  | 23 MV/m                                    |
| limitation                           | quench, no radiation       | quench, no radiation  | quench, no radiation  | quench, small radiation    | quench, no radiation           | quench, no radiation                                   | quench, no radiation                       |
| OST results                          | quench at 1 location       | quench at 2 locations   | quench at 1 location  | large quench region        | Global quench                  | quench at 1 location                                   | quench at 1 location                       |
| highest Q <sub>0</sub> at low fields | 3x10 <sup>10</sup> at 1.8K | 9x10 <sup>10</sup> at 1.4K  | 3x10 <sup>10</sup> at 1.8K  | 7x10 <sup>10</sup> at 1.4K | 8x10 <sup>10</sup> at 1.6K     | 3x10 <sup>10</sup> at 1.4K                             | 6x10 <sup>10</sup> at 1.4K                 |
| optical inspection result            | No defects observed        | No defects near quench locations, but pits and bumps at other locations | No defects near quench locations, but pits and bumps at other locations | No defects observed        | Some discolored spots observed | Rough area near weld and grain boundaries. Mold taken. | Rough area near weld and grain boundaries. |



Some conclusions can be made based on these tests.

- AES02, AES06, NR1-2, and NR1-3 show that **quenches without radiation at 25-40 MV/m can occur in locations with no topological defects**
- Whether or not these type of quenches occur **does not seem to depend on the manufacturer**
- VEP can reliably produce cavities with very good low-field Qs
- VEP can produce cavities with accelerating fields exceeding 40 MV/m

These tests do not point to any particular cause for quenches at 25-40 MV/m without radiation. To investigate further, a full-cavity single cell T-map is being commissioned that will fit both ILC and Cornell ERL shape cavities. Several cavities will be fabricated and tested with T-map. After testing, the cavities will be dissected, and surface studies will be performed on any hot spots.

